

2N6406, 2N6407 PNP (SILICON)

2N6408, 2N6409 NPN

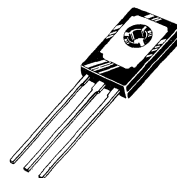
COMPLEMENTARY PLASTIC SILICON ANNULAR POWER TRANSISTORS

... designed for low power audio amplifier and low current, high speed switching applications.

- Collector-Emitter Sustaining Voltage —
 $V_{CE(sus)} = 60 \text{ Vdc} - 2N6406, 2N6408$
 $= 80 \text{ Vdc} - 2N6407, 2N6409$
- DC Current Gain —
 $h_{FE} = 30 \text{ (Min) @ } I_C = 0.5 \text{ Adc}$
 $= 12 \text{ (Min) @ } I_C = 1.5 \text{ Adc}$
- Current-Gain — Bandwidth Product —
 $f_T = 50 \text{ MHz (Min) @ } I_C = 100 \text{ mAdc}$
- Pin Compatible With TO-220AB Package

2 AMPERE POWER TRANSISTORS COMPLEMENTARY SILICON

60-80 VOLTS
12.5 WATTS



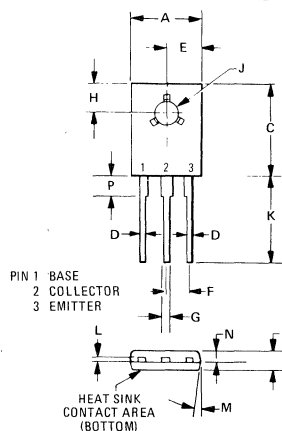
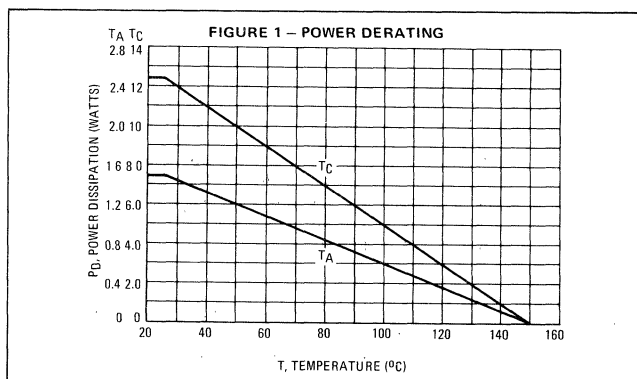
*MAXIMUM RATINGS

Rating	Symbol	2N6406 2N6408	2N6407 2N6409	Unit
Collector-Emitter Voltage	V _{CEO}	60	80	V _{dc}
Collector-Base Voltage	V _{CBO}	80	100	V _{dc}
Emitter-Base Voltage	V _{EB}	6.0		V _{dc}
Collector Current – Continuous Peak	I _C	2.0		A _{dc}
		4.0		
Base Current	I _B	1.0		A _{dc}
Total Power Dissipation @ T _C = 25°C Derate Above 25°C	P _D	12.5		Watts W/°C
		0.10		
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150		°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	10	$^\circ\text{C/W}$

*Indicates JEDEC Registered Data.



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.295	0.305	7.490	7.750
B	0.095	0.105	2.410	2.670
C	0.425	0.435	10.800	11.050
D	0.020	0.026	0.508	0.660
E	0.145	0.155	3.680	3.940
F	0.093 TP; 2.360 TP			
G	0.025	0.035	0.635	0.889
H	0.148	0.158	3.760	4.010
J	0.115	0.118	2.920	3.000
K	0.595	0.645	15.110	16.380
L	0.015	0.025	0.381	0.635
M	30 TYP			
N	0.045	0.055	1.140	1.400
P	0.085	0.095	2.160	2.410

CASE 77-03

2N6406, 2N6407 PNP/2N6408, 2N6409 NPN (continued)

*ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Sustaining Voltage (1) (I _C = 10 mA _{dc} , I _B = 0)	V _{CEO(sus)}	60 80	—	V _{dc}
Collector Cutoff Current (V _{CE} = 30 V _{dc} , I _B = 0)	I _{CEO}	—	500	μA _{dc}
Collector Cutoff Current (V _{CE} = 40 V _{dc} , I _B = 0)	I _{CEO}	—	500	μA _{dc}
Collector Cutoff Current (V _{CE} = 80 V _{dc} , V _{BE(off)} = 1.5 V _{dc})	I _{CEX}	—	1.0	μA _{dc}
(V _{CE} = 100 V _{dc} , V _{BE(off)} = 1.5 V _{dc})		—	1.0	μA _{dc}
(V _{CE} = 40 V _{dc} , V _{BE(off)} = 1.5 V _{dc})		—	0.1	mA _{dc}
T _C = 125°C				
(V _{CE} = 50 V _{dc} , V _{BE(off)} = 1.5 V _{dc} , T _C = 125°C)		—	0.1	mA _{dc}
Emitter Cutoff Current (V _{EB} = 6.0 V _{dc} , I _C = 0)	I _{EBO}	—	1.0	μA _{dc}

ON CHARACTERISTICS (1)

DC Current Gain (I _C = 100 mA _{dc} , V _{CE} = 2.0 V _{dc})	h _{FE}	50	250	—
(I _C = 500 mA _{dc} , V _{CE} = 2.0 V _{dc})		30	—	
(I _C = 1.5 A _{dc} , V _{CE} = 2.0 V _{dc})		12	—	
(I _C = 2.0 A _{dc} , V _{CE} = 2.0 V _{dc})		5.0	—	
Collector-Emitter Saturation Voltage (I _C = 500 mA _{dc} , I _B = 50 mA _{dc})	V _{CE(sat)}	—	0.5	V _{dc}
(I _C = 1.5 A _{dc} , I _B = 150 mA _{dc})		—	1.4	
(I _C = 2.0 A _{dc} , I _B = 400 mA _{dc})		—	2.0	
Base-Emitter Saturation Voltage (I _C = 1.5 A _{dc} , I _B = 150 mA _{dc})	V _{BE(sat)}	—	1.5	V _{dc}
Base-Emitter on Voltage (I _C = 100 mA _{dc} , V _{CE} = 2.0 V _{dc})	V _{BE(on)}	—	1.2	V _{dc}

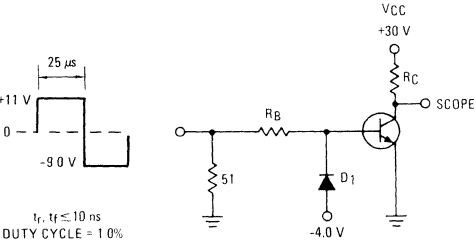
DYNAMIC CHARACTERISTICS

Current-Gain — Bandwidth Product (I _C = 100 mA _{dc} , V _{CE} = 10 V _{dc} , f = 10 MHz)	f _T	50	—	MHz
Output Capacitance (V _{CB} = 10 V _{dc} , I _E = 0, f = 0.1 MHz)	C _{ob}	—	50	pF
		—	30	
Small-Signal Current Gain (I _C = 100 mA _{dc} , V _{CE} = 10 V _{dc} , f = 1.0 kHz)	h _{fe}	10	—	—

*Indicates JEDEC Registered Data.

(1) Pulse test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%.

FIGURE 2 — SWITCHING TIME TEST CIRCUIT



R_B and R_C VARIED TO OBTAIN DESIRED CURRENT LEVELS

D₁ MUST BE FAST RECOVERY TYPE, eg
MBD5300 USED ABOVE I_B > 100 mA
MSD6100 USED BELOW I_B > 100 mA

FOR PNP TEST CIRCUIT, REVERSE ALL POLARITIES.

FIGURE 3 — TURN-ON TIME

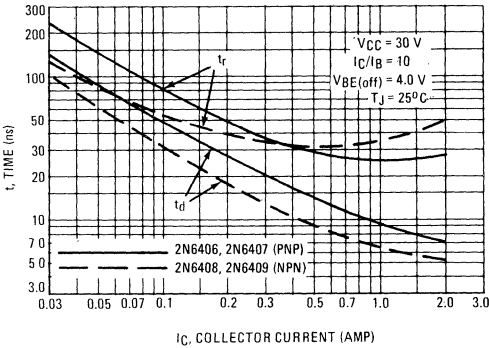
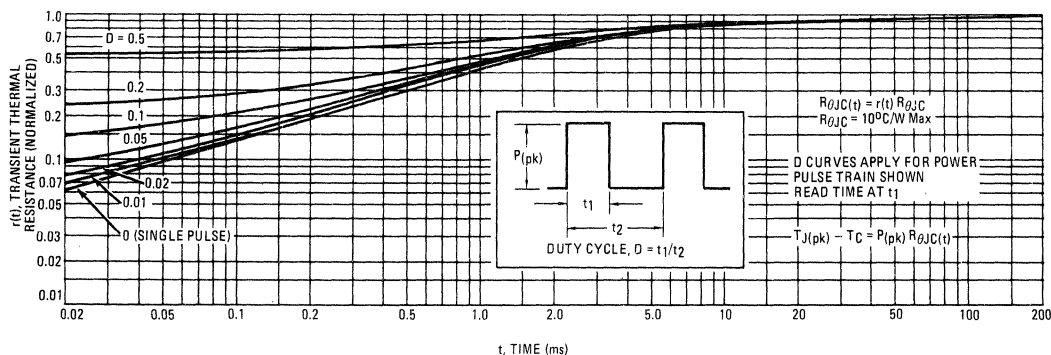
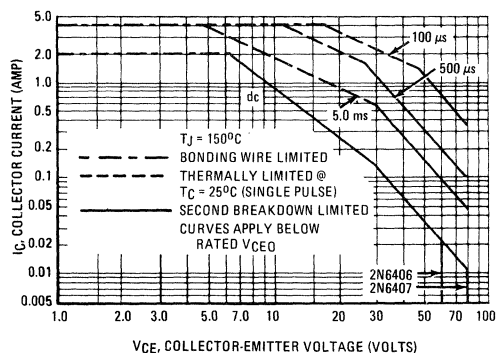


FIGURE 4 – THERMAL RESPONSE



ACTIVE-REGION SAFE OPERATING AREA

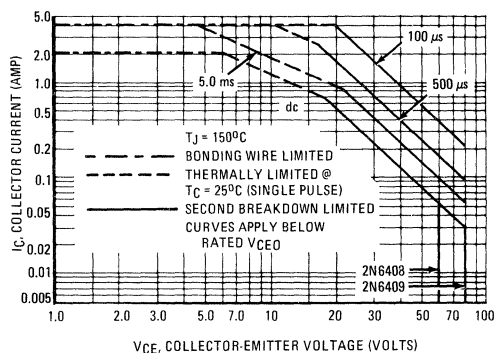
FIGURE 5 – 2N6406, 2N6407



There are two limitations on the power handling ability of a transistor — average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figures 5 and 6 is based on $T_{J(pk)} = 150^\circ\text{C}$; T_C is

FIGURE 6 – 2N6408, 2N6409



variable depending on conditions. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(pk)} < 150^\circ\text{C}$. $T_{J(pk)}$ may be calculated from the data in Figure 4. At high case temperature, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. (See AN-415A)

FIGURE 7 – TURN-OFF TIME

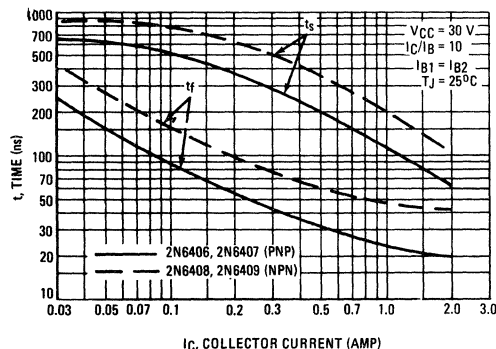
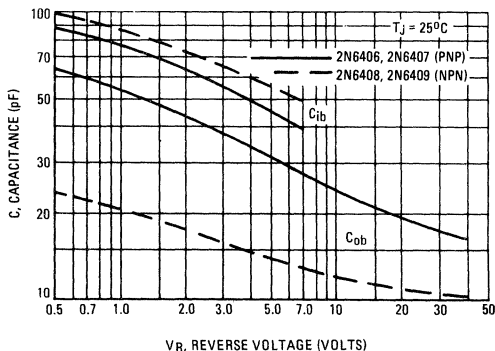


FIGURE 8 – CAPACITANCE



2N6406, 2N6407 PNP/2N6408, 2N6409 NPN (continued)

PNP
2N6406, 2N6407

NPN
2N6408, 2N6409

FIGURE 9 – DC CURRENT GAIN

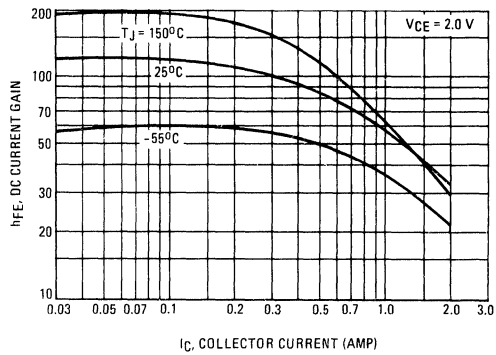
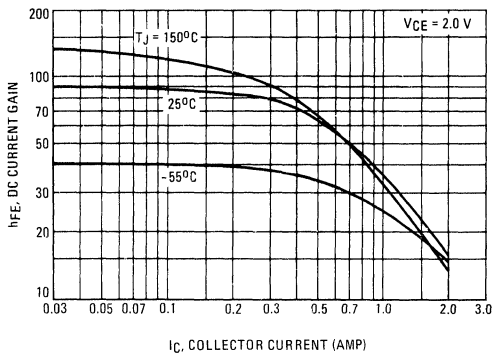


FIGURE 10 – "ON" VOLTAGES

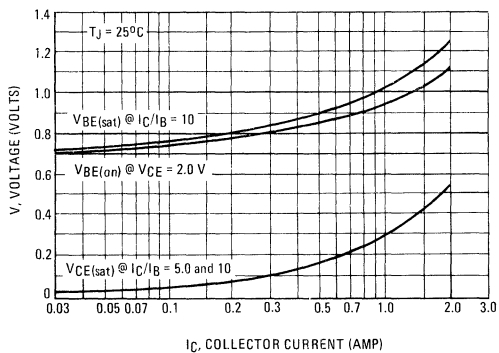
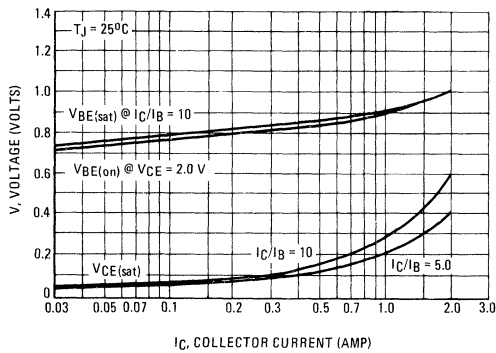


FIGURE 11 – TEMPERATURE COEFFICIENTS

